Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10574052	TAKAHASḤI ET AL.
Examiner	Art Unit
Lucas Stelling	1797

SEARCHED				
Class	Subclass	Date	Examiner	
210	748+, 749, 760, 761, 765, 766, 167.01, 194, 195.1, 198.1, 205,	2/18/2010	/LS/	
261	76, 94	2/18/2010	/LS/	
366	336, 340, 174.1, 175.2,	2/18/2010	/LS/	
138	40, 41	2/18/2010	/LS/	

SEARCH NOTES			
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keywords used microbubble, nanobubble, cavitation, micron, nozzle,	2/18/2010	/LS/	
search updated	11/16/2010	/LS/	

	INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner	

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